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	Application Number		10608441		
INFORMATION BIOCH COURT	Filing Date		2003-06-27		
INFORMATION DISCLOSURE	First Named Inventor	Elie H	lelou, Jr.		
STATEMENT BY APPLICANT (Not for submission under 37 CFR 1.99)	Art Unit		1791		
	Examiner Name	Thukh	nanh T. Nguyen		
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/TN/	2	5412005		1995-05-02	Bastioli et al.					
/TN/	3	5376320		1994-12-27	Tiefenbacher et al.					
/TN/	4	6585859	B1	2003-07-01	Hakansson					
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/TN/	2	20050	089606	A1	2005-04-28		Dellinger e	t al.					
/TN/	3	20060	110498	A1	2006-05	006-05-25 Dellinger et al.							
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